

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/823,699	KANO ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Genome database for SHIV, NCBI. 2005. ✓
	V	Hirsch et al, J Virol 1996;3741-52. ✓
	W	Robbins et al, Pharmcol Ther 1998;80:35-47. ✓
	X	Moingeon et al, Trends Immunol 2002 Apr;23:173-5. ✓

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Matano et al, AIDS 2003;17:1392-4.
	V	McCluskie et al, Mol Med 1999 May;5:287-300.
	W	Torres et al, J Immunol 1997;158:4529-32.
	X	Nakano et al, J Virol 1997;71:7101-09.

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